1 GHz to 60 GHz, Reflective, Silicon SPDT Switch

FEATURES

- Ultra-wideband frequency range: 1 GHz to 60 GHz
- Reflective design
- Low insertion loss
  - 1.3 dB typical up to 40 GHz
  - 1.9 dB typical up to 55 GHz
  - 2.0 dB typical up to 60 GHz
- High isolation
  - 43 dB typical up to 40 GHz
  - 37 dB typical up to 55 GHz
  - 32 dB typical up to 60 GHz
- High input linearity
  - P0.1dB: 24 dBm typical
  - IP3: 45 dBm typical
- High-RF power handling
  - Through path: 24 dBm
  - Hot switching path: 21 dBm
- CMOS/LVTTL compatible
- No low-frequency spur
- RF switching time: 15 ns
- RF settling time (50% V_{CTRL} to 0.1 dB of RF output): 35 ns
- Dual-supply operation: ±3.3 V
- 12-terminal, 2.5 mm × 2.5 mm, RoHS-compliant, LGA package

APPLICATIONS

- Industrial scanners
- Test and instrumentation
- Cellular infrastructure: 5G mmWave
- Military radios, radars, electronic counter measures (ECMs)
- Microwave radios and very small aperture terminals (VSATs)

FUNCTIONAL BLOCK DIAGRAM

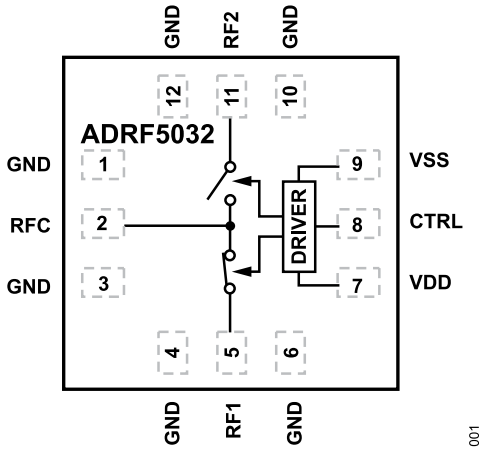

Figure 1. Functional Block Diagram

GENERAL DESCRIPTION

The ADRF5032 is a reflective, single-pole double-throw (SPDT) switch manufactured using the silicon process. The ADRF5032 operates from 1 GHz to 60 GHz with insertion loss of lower than 2.0 dB and isolation of higher than 32 dB. The device has a RF input power handling capability of 24 dBm for both through paths and 21 dBm for hot switching.

The ADRF5032 requires dual supply voltages of ±3.3 V. The device employs CMOS and low-voltage transistor logic (LVTTL) compatible control.

The ADRF5032 is packaged in a 12-terminal, 2.5 mm × 2.5 mm, RoHS-compliant, land grid array (LGA). The ADRF5032 operates from −40°C to +105°C.

TABLE OF CONTENTS

REVISION HISTORY

2/2023—Revision 0: Initial Version

SPECIFICATIONS

V_{DD} = 3.3 V, V_{SS} = −3.3 V, V_{CTL} = 0 V or VDD, T_{CASE} = 25°C, 50 Ω system, unless otherwise noted. RFx refers to RF1 or RF2.

Table 1. Electrical Characteristics

Parameter	Symbol	Test Conditions/Comments	Min	Typ	Max	Unit
FREQUENCY RANGE	f		1		60	GHz
INSERTION LOSS						
Between RFC and RFx (On)		1 GHz to 18 GHz		1.1		dB
		18 GHz to 40 GHz		1.3		dB
		40 GHz to 55 GHz		1.9		dB
		55 GHz to 60 GHz		2.0		dB
ISOLATION						
Between RFC and RFx		1 GHz to 18 GHz		46		dB
		18 GHz to 40 GHz		43		dB
		40 GHz to 55 GHz		37		dB
		55 GHz to 60 GHz		32		dB
Between RFx and RFx		1 GHz to 18 GHz		50		dB
		18 GHz to 40 GHz		45		dB
		40 GHz to 55 GHz		40		dB
		55 GHz to 60 GHz		36		dB
RETURN LOSS						
RFC		1 GHz to 18 GHz		22		dB
		18 GHz to 40 GHz		17		dB
		40 GHz to 55 GHz		16		dB
		55 GHz to 60 GHz		18		dB
RFx		1 GHz to 18 GHz		24		dB
		18 GHz to 40 GHz		23		dB
		40 GHz to 55 GHz		19		dB
		55 GHz to 60 GHz		18		dB
SWITCHING						
Rise and Fall Time	t_{RISE},t_{FALL}	10% to 90% of RF output		5		ns
On and Off Time	t_{ON}, t_{OFF}	50% V_{CTL} to 90% of RF output		15		ns
Settling Time						
0.1 dB		50% V_{CTL} to 0.1 dB of final RF output		35		ns
INPUT LINEARITY[1]		f = 3 GHz to 60 GHz				
Input Compression	P0.1dB			24		dBm
Third-Order Intercept	IP3	Two-tone input power = 12 dBm each tone, Δf = 1 MHz		45		dBm
SUPPLY CURRENT		VDD and VSS pins				
Positive Supply Current	I_{DD}			15		µA
Negative Supply Current	I_{SS}			370		µA
DIGITAL CONTROL INPUTS		CTRL pin				
Voltage						
Low	V_{INL}		0		0.8	V
High	V_{INH}		1.2		3.3	V
Current						
Low	I_{INL}			<1		µA
High	I_{INH}			<1		µA
RECOMMENDED OPERATING CONDITIONS						
Supply Voltage						
Positive	V_{DD}		3.15		3.45	V
Negative	V_{SS}		−3.45		−3.15	V

SPECIFICATIONS

Table 1. Electrical Characteristics (Continued)

Parameter	Symbol	Test Conditions/Comments	Min	Typ	Max	Unit
Digital Control Inputs Voltage	V_{CTL}		0		VDD	V
RF Input Power[2,3]	P_{IN}	f = 3 GHz to 60 GHz, T_{CASE} = 85°C				
Through Path		RF signal is applied to RFC or through connected RF1/RF2			24	dBm
Hot Switching		RF signal is applied to RFC or through connected RF1/RF2			21	dBm
Case Temperature	T_{CASE}		−40		+105	°C

[1] For input linearity performance over frequency, see Figure 12 to Figure 15.

[2] For power derating over frequency, see Figure 2.

[3] For 105°C operation, the power handling degrades from the T_{CASE} = 85°C specification by 3 dB.

ABSOLUTE MAXIMUM RATINGS

For the recommended operating conditions, see Table 1.

Table 2. Absolute Maximum Ratings

Parameter	Rating
Positive Supply Voltage	-0.3 V to +3.6 V
Negative Supply Voltage	−3.6 V to +0.3 V
Digital Control Input[1]	
Voltage	−0.3 V to V_{DD} + 0.3 V
Current	3 mA
RF Input Power[2] (f = 3 GHz to 67 GHz, T_{CASE} = 85°C[3])	
Through Path	24.5 dBm
Hot Switching (RFC)	21.5 dBm
RF Input Power, Unbiased (V_{DD}, V_{SS} = 0V)	15 dBm
Temperature	
Junction, T_J	135°C
Storage Range	−65°C to +150°C
Reflow	260°C

1 Overvoltages at the digital control input are clamped by internal diodes. Current must be limited to the maximum rating given.

2 For power derating over frequency, see Figure 2.

3 For 105°C operation, the power handling degrades from the T_{CASE} = 85°C specification by 3 dB.

Stresses at or above those listed under Absolute Maximum Ratings may cause permanent damage to the product. This is a stress rating only; functional operation of the product at these or any other conditions above those indicated in the operational section of this specification is not implied. Operation beyond the maximum operating conditions for extended periods may affect product reliability.

Only one absolute maximum rating can be applied at any one time.

THERMAL RESISTANCE

Thermal performance is directly linked to printed circuit board (PCB) design and operating environment. Careful attention to PCB thermal design is required.

θ_{JC} is the junction-to-case bottom (channel-to-package bottom) thermal resistance.

Table 3. Thermal Resistance

Package Type	θ_{JC}[1]	Unit
CC-12-07, Through Path	476	°C/W

1 θ_{JC} was determined by simulation under the following conditions: the heat transfer is due solely to the thermal conduction from the channel through the ground pad to the PCB, and the ground pad is held constant at the operating temperature of 85°C.

POWER DERATING CURVES

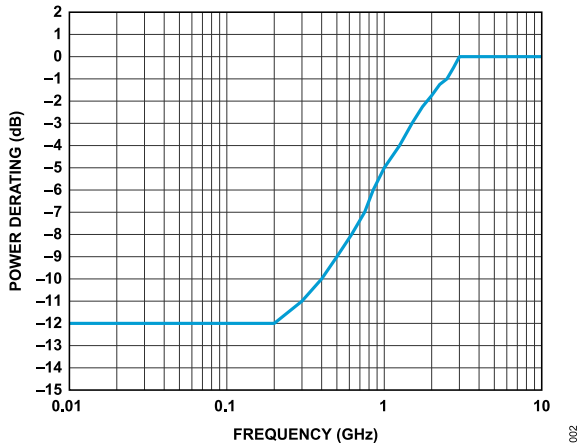

Figure 2. Power Derating vs. Frequency, Low-Frequency Detail, T_{CASE} = 85°C.

ELECTROSTATIC DISCHARGE (ESD) RATINGS

The following ESD information is provided for handling of ESD-sensitive devices in an ESD-protected area only.

Human body model (HBM) per ANSI/ESDA/JEDEC JS-001. Charged device model (CDM) ratings are per ANSI/ESDA/JEDEC JS-002.

ESD Ratings for the ADRF5032

Table 4. ADRF5032, 20-Terminal LGA

ESD Model	Withstand Threshold (V)
HBM	±750 for RF Pins
	±2000 for Supply and Digital Control Pins
CDM	±500 for All Pins

ESD CAUTION

ESD (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

PIN CONFIGURATION AND FUNCTION DESCRIPTIONS

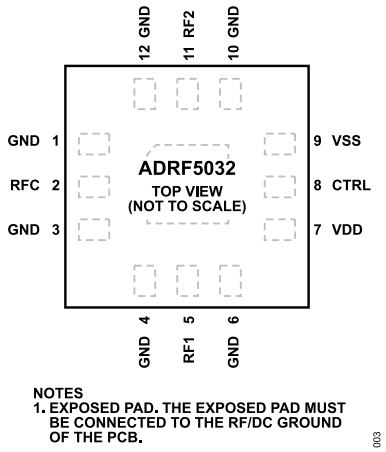

Figure 3. Pin Configuration (Top View)

Table 5. Pin Function Descriptions

Pin No.	Mnemonic	Description
1, 3, 4, 6, 10, 12	GND	Ground. These pins must be connected to the RF/DC ground of the PCB.
2	RFC	RF Common Port. This pin is DC-coupled to 0 V. No DC-blocking capacitor is necessary when the RF line potential is equal to 0 V DC. See Figure 4 for the interface schematic.
5	RF1	RF Port 1. This pin is DC-coupled to 0 V. No DC-blocking capacitor is necessary when the RF line potential is equal to 0 V DC. See Figure 4 for the interface schematic.
7	VDD	Positive Supply Voltage. See Figure 5 for the interface schematic.
8	CTRL	Control Input Voltage. See Figure 6 for the interface schematic.
9	VSS	Negative Supply Voltage. See Figure 7 for the interface schematic.
11	RF2	RF Port 2. This pin is DC-coupled to 0 V. No DC-blocking capacitor is necessary when the RF line potential is equal to 0 V DC. See Figure 4 for the interface schematic.
	EPAD	Exposed Pad. The exposed pad must be connected to the RF/DC ground of the PCB.

INTERFACE SCHEMATICS

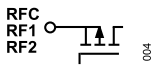

Figure 4. RFx Pins Interface Schematic

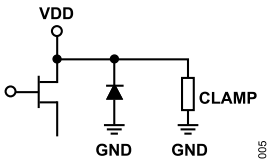

Figure 5. VDD Interface Schematic

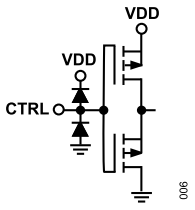

Figure 6. CTRL Pin Interface Schematic

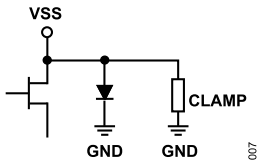

Figure 7. VSS Interface Schematic

TYPICAL PERFORMANCE CHARACTERISTICS

INSERTION LOSS, RETURN LOSS, AND ISOLATION

V_{DD} = 3.3 V, V_{SS} = –3.3 V, V_{CTRL} = 0 V or V_{DD}, and T_{CASE} = 25°C, and a 50 Ω system, unless otherwise noted. RFx refers to RF1 to RF2.

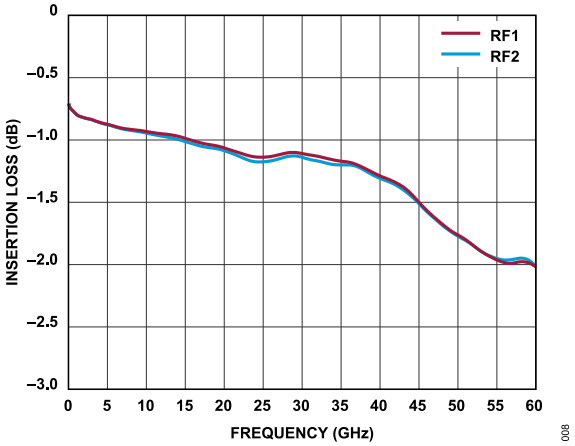

Figure 8. Insertion Loss vs. Frequency RF1 and RF2

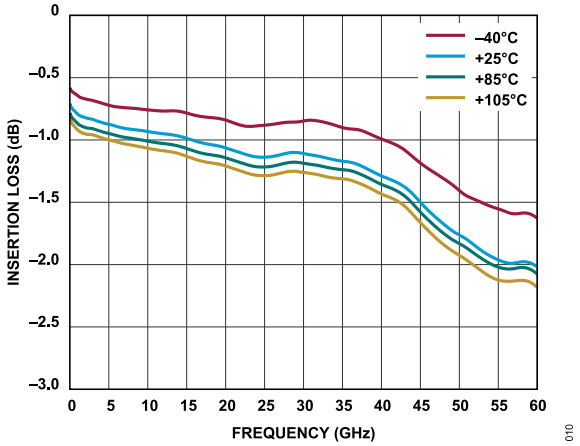

Figure 10. Insertion Loss vs. Frequency over Various Temperatures

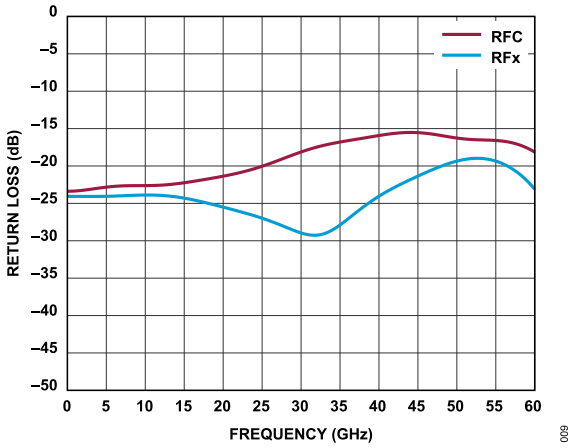

Figure 9. Return Loss vs. Frequency

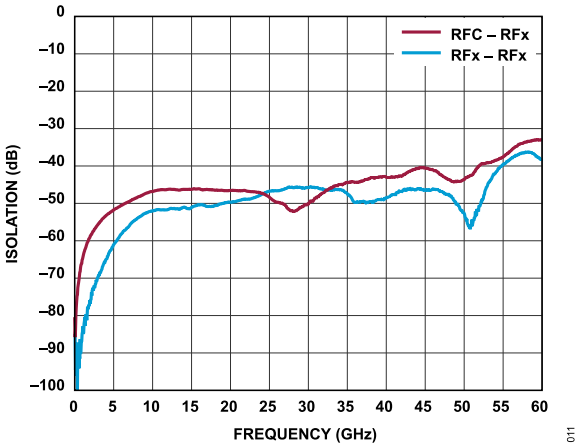

Figure 11. Isolation vs. Frequency

TYPICAL PERFORMANCE CHARACTERISTICS

INPUT POWER COMPRESSION AND THIRD-ORDER INTERCEPT

V_{DD} = 3.3 V, V_{SS} = −3.3 V, V_{CTRL} = 0 V or V_{DD}, and T_{CASE} = 25°C for a 50 Ω system, unless otherwise noted.

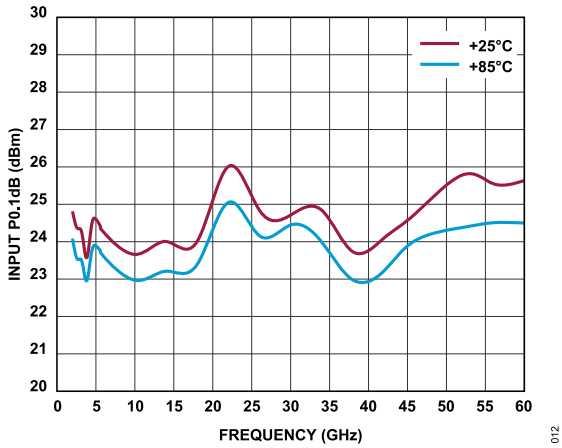

Figure 12. Input P0.1dB vs. Frequency

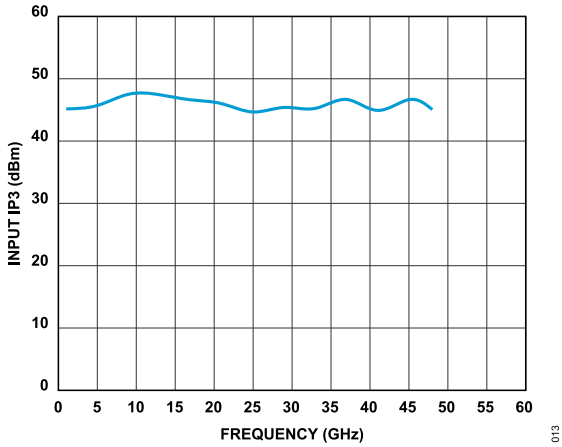

Figure 13. Input IP3 vs. Frequency

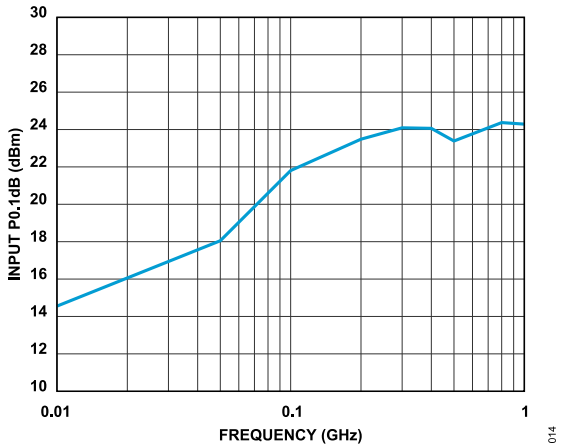

Figure 14. Input P0.1dB vs. Frequency (Low-Frequency Detail)

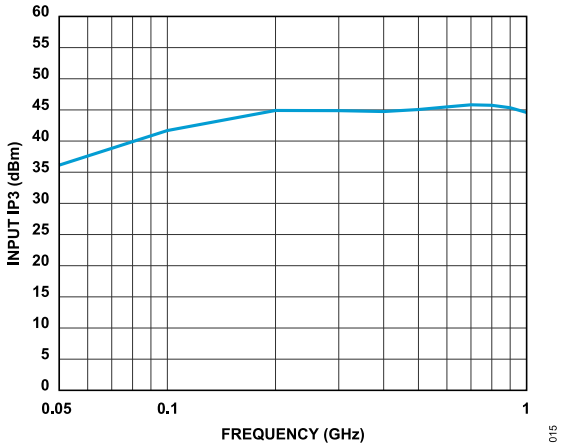

Figure 15. Input IP3 vs. Frequency (Low-Frequency Detail)

THEORY OF OPERATION

The ADRF5032 can connect to CMOS/LVTTL-compatible control interfaces directly.

The CTRL pin determines which RF port is in the insertion loss state and in the isolation state. See Table 6 for the control voltage truth table.

RF INPUT AND OUTPUT

The RF ports (RFC, RF1, and RF2) are DC-coupled to 0 V, and no DC-blocking is required at the RF ports when the RF line potential is equal to 0 V.

The RF ports are internally matched to 50 Ω. However, impedance matching on transmission lines can be used to improve insertion loss and return loss performance at high frequencies.

The ADRF5032 is bidirectional with equal power-handling capabilities. The RF input signal can be applied to the RFC port or the selected RF throw port.

The insertion loss path conducts the RF signal between the selected RF throw port and the RF common port. The isolation paths provide high loss between the insertion loss path and the unselected RF throw port that is reflective.

The power handling of the ADRF5032 derates with frequencies below 3 GHz. See Figure 2 for derating of the RF power towards lower frequencies.

POWER SUPPLY

The ADRF5032 requires that a positive supply voltage is applied to the VDD pin and a negative supply voltage to the VSS pin. Bypassing capacitors are recommended on the supply lines to minimize RF coupling.

The unselected RF port of the ADRF5032 is reflective. The isolation path provides high isolation between the unselected port and the insertion loss path.

The ideal power-up sequence is as follows:

1. Connect GND.
2. Power up VDD and VSS. Power up VSS after VDD to avoid current transients on VDD during ramp up.
3. Power up the digital control inputs. The relative order of the logic control inputs is not important. However, powering the digital control inputs before the VDD supply can inadvertently forward-bias and damage the internal ESD-protection structures.
4. Apply signals to the RF input port. The design is bidirectional—the input signal can be applied to the RFC port while the RF throw ports are outputs or vice versa.

The ideal power-down sequence is the reverse of the above.

Table 6. Control Voltage Truth Table

Digital Control Input	RF Path	
CTRL	RF1 to RFC	RF2 to RFC
Low	Isolation (off)	Insertion loss (on)
High	Insertion loss (on)	Isolation (off)

APPLICATIONS INFORMATION

EVALUATION BOARD

The ADRF5032 has two power-supply pins (VDD and VSS) and one control pin (CTRL). Figure 16 shows the external components and connections for the supply pin. The VDD and VSS pins are decoupled with a 100 pF multilayer ceramic capacitor. The device pinout allows the placement of the decoupling capacitors close to the device. No other external components are needed for bias and operation, except DC-blocking capacitors on the RF pins when the RF lines are biased at a voltage other than 0 V. See Table 5 and the Pin Configuration and Function Descriptions section for details.

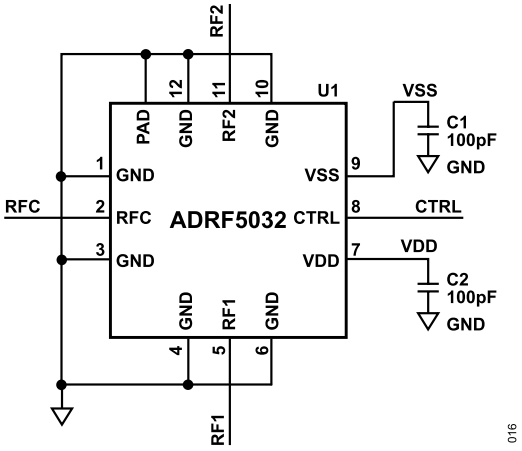

Figure 16. Recommended Schematic

RECOMMENDATIONS FOR PRINTED CIRCUIT BOARD DESIGN

The RF ports are matched to 50 Ω internally and the pinout is designed to mate a coplanar waveguide (CPWG) with 50 Ω characteristic impedance on the PCB. Figure 17 shows the referenced CPWG RF trace design for an RF substrate with 8 mil thick Rogers RO4003C dielectric material. RF trace with 16 mil width and 13 mil clearance is recommended for 1.7 mil finished copper thickness.

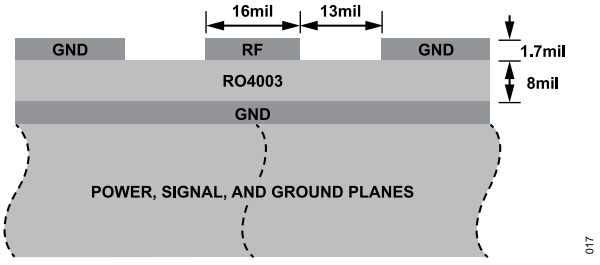

Figure 17. Example PCB Stack-up

Figure 18 shows the routing of the RF traces, supply, and control signals from the device. The ground planes are connected with densely filled through vias for optimal RF and thermal performance. The primary thermal path for the device is the bottom side.

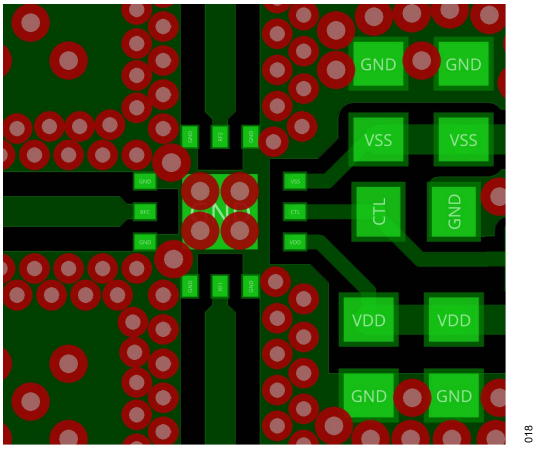

Figure 18. PCB Layout

Figure 19 shows the recommended layout from the device RF pins to the 50 Ω CPWG on the referenced stack-up. PCB pads are drawn 1:1 to device pads. The ground pads are drawn soldermask defined and the signal pads are drawn as pad defined. The RF trace from the PCB pad is extended with the same width to the package edge and tapered to RF trace. The paste mask is designed to match the device pads without any aperture reduction. The paste mask is divided into multiple openings for the paddle.

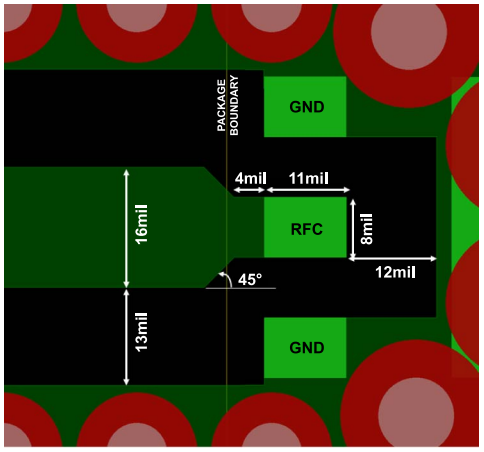

Figure 19. Recommended RF Pin Transition

For alternate PCB stack-ups with different dielectric thickness and RF trace design, contact Analog Devices Technical Support for further recommendations.

OUTLINE DIMENSIONS

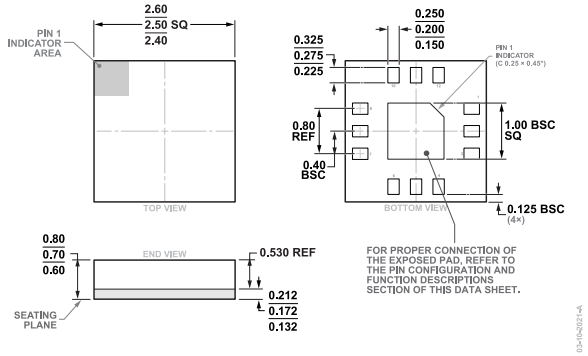

Figure 20. 12-Terminal Land Grid Array [LGA]
2.5 mm × 2.5 mm Body and 0.7 mm Package Height (CC-12-7)
Dimensions Shown in Millimeters

ORDERING GUIDE

Model[1]	Temperature Range	Package Description	Package Option	Marking Code
ADRF5032BCCZN	−40°C to +105°C	12-Terminal Land Grid Array [LGA]	CC-12-7	
ADRF5032BCCZN-R7	−40°C to +105°C	12-Terminal Land Grid Array [LGA]	CC-12-7	

[1] Z = RoHS-compliant part.

EVALUATION BOARDS

Table 7. Evaluation Boards

Model[1]	Description
ADRF5032-EVALZ	Evaluation Board

[1] Z = RoHS-Compliant Part.

Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

Analog Devices Inc.:

ADRF5032BCCZN ADRF5032BCCZN-R7